

DATA SHEET

PHC2300

Complementary enhancement
mode MOS transistors

Product specification
Supersedes data of 1997 Jun 19
File under Discrete Semiconductors, SC13b

1997 Oct 24

Complementary enhancement mode MOS transistors

PHC2300

FEATURES

- High-speed switching
- No secondary breakdown.

APPLICATIONS

- Universal line interface in telephone sets
- Relay, high-speed and line transformer drivers.

DESCRIPTION

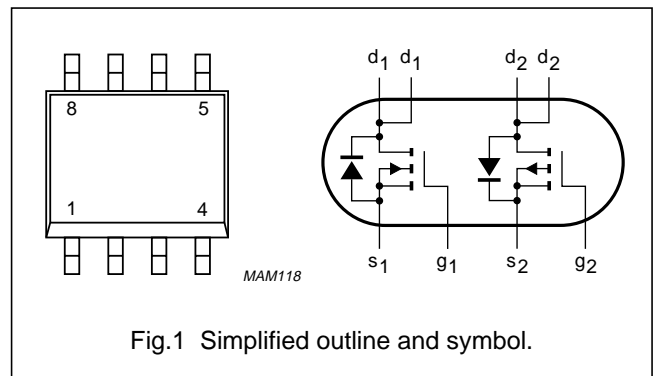
One N-channel and one P-channel enhancement mode MOS transistor in an 8-pin plastic SOT96-1 (SO8) package.

PINNING - SOT96-1 (SO8)

PIN	SYMBOL	DESCRIPTION
1	s ₁	source 1
2	g ₁	gate 1
3	s ₂	source 2
4	g ₂	gate 2
5	d ₂	drain 2
6	d ₂	drain 2
7	d ₁	drain 1
8	d ₁	drain 1

CAUTION

The device is supplied in an antistatic package.
The gate-source input must be protected against static discharge during transport or handling.



QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per FET					
V _{DS}	drain-source voltage (DC) N-channel P-channel		–	300 –300	V V
V _{GS}	gate-source voltage (DC)		–	±20	V
V _{GSth}	gate-source threshold voltage N-channel P-channel	V _{DS} = V _{GS} ; I _D = 1 mA V _{DS} = V _{GS} ; I _D = –1 mA	0.8 –0.8	2 –2	V V
I _D	drain current (DC) N-channel P-channel	T _s = 80 °C	–	340 –235	mA mA
R _{DSon}	drain-source on-state resistance N-channel P-channel	V _{GS} = 10 V; I _D = 170 mA V _{GS} = –10 V; I _D = –115 mA	–	8 17	Ω Ω
P _{tot}	total power dissipation	T _s = 80 °C	–	1.6	W

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

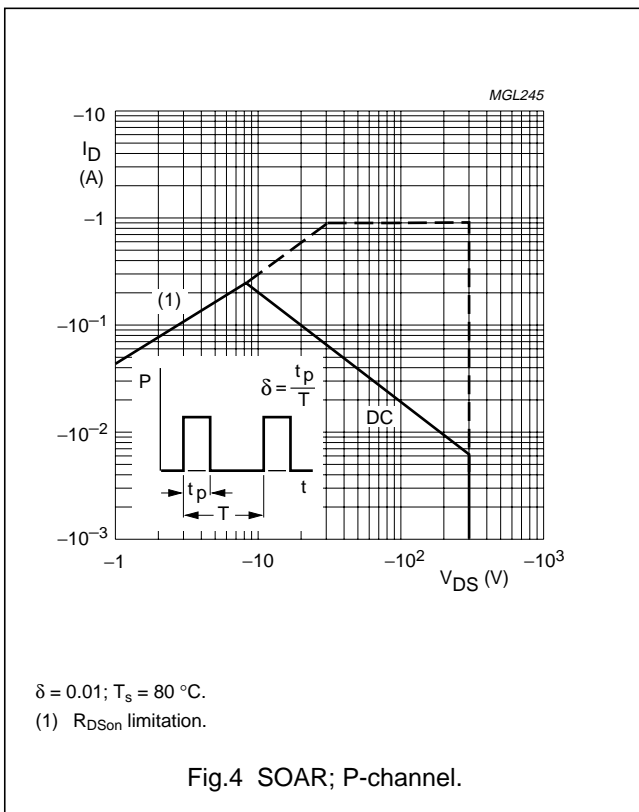
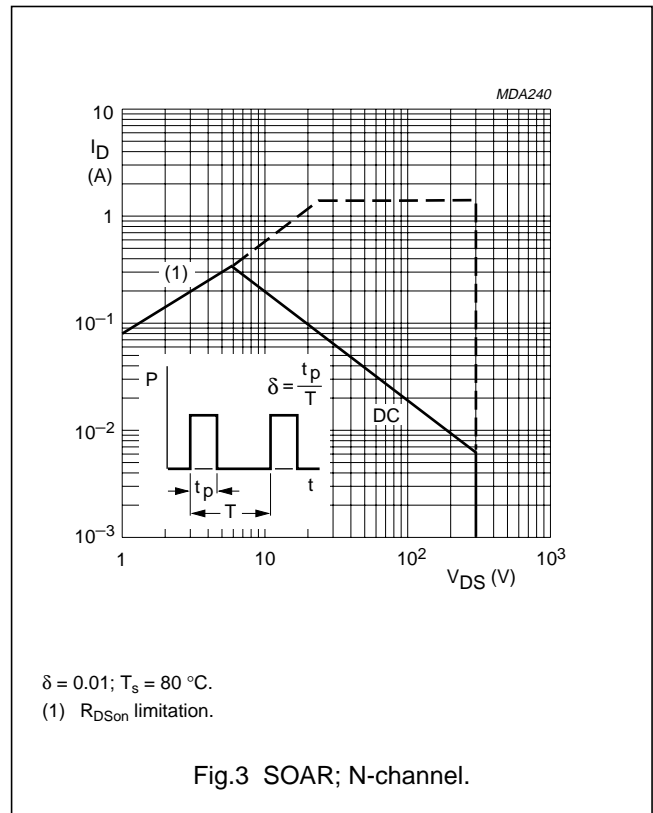
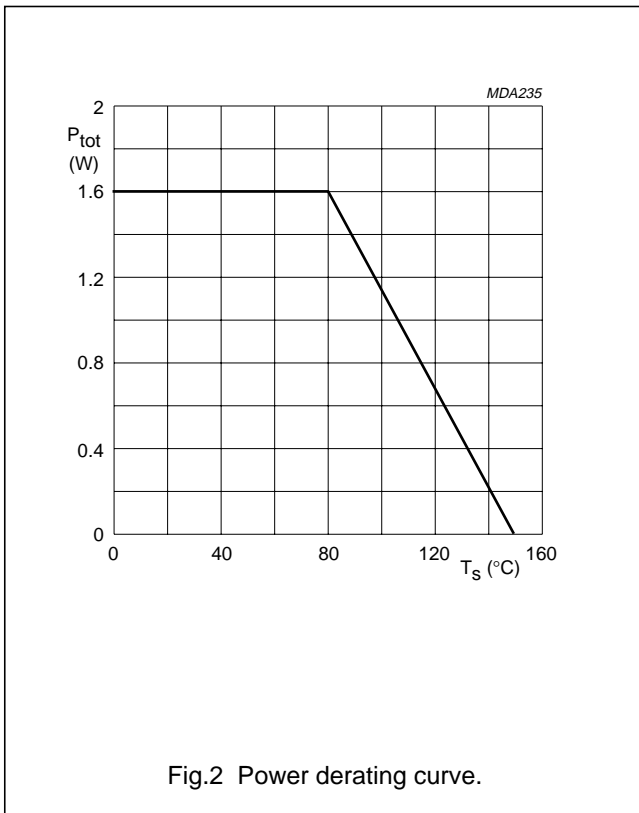
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per FET					
V _{DS}	drain-source voltage (DC)				
	N-channel		–	300	V
	P-channel		–	–300	V
V _{GS}	gate-source voltage (DC)		–	±20	V
I _D	drain current (DC)	T _s = 80 °C; note 1			
	N-channel		–	340	mA
	P-channel		–	–235	mA
I _{DM}	peak drain current	note 2			
	N-channel		–	1.4	A
	P-channel		–	–0.9	A
P _{tot}	total power dissipation	T _s = 80 °C; note 3	–	1.6	W
		T _{amb} = 25 °C; note 4	–	1.8	W
		T _{amb} = 25 °C; note 5	–	0.9	W
		T _{amb} = 25 °C; note 6	–	1.2	W
T _{stg}	storage temperature		–55	+150	°C
T _j	operating junction temperature		–55	+150	°C

Notes

1. T_s is the temperature at the soldering point of the drain leads.
2. Pulse width and duty cycle limited by maximum junction temperature.
3. Maximum permissible dissipation per MOS transistor. (So both devices may be loaded up to 1.6 W at the same time).
4. Maximum permissible dissipation per MOS transistor. Value based on a printed-circuit board with an R_{th a-tp} (ambient to tie-point) of 27.5 K/W.
5. Maximum permissible dissipation per MOS transistor. Value based on a printed-circuit board with an R_{th a-tp} (ambient to tie-point) of 90 K/W.
6. Maximum permissible dissipation if only one MOS transistor dissipates. Value based on a printed-circuit board with an R_{th a-tp} (ambient to tie-point) of 90 K/W.

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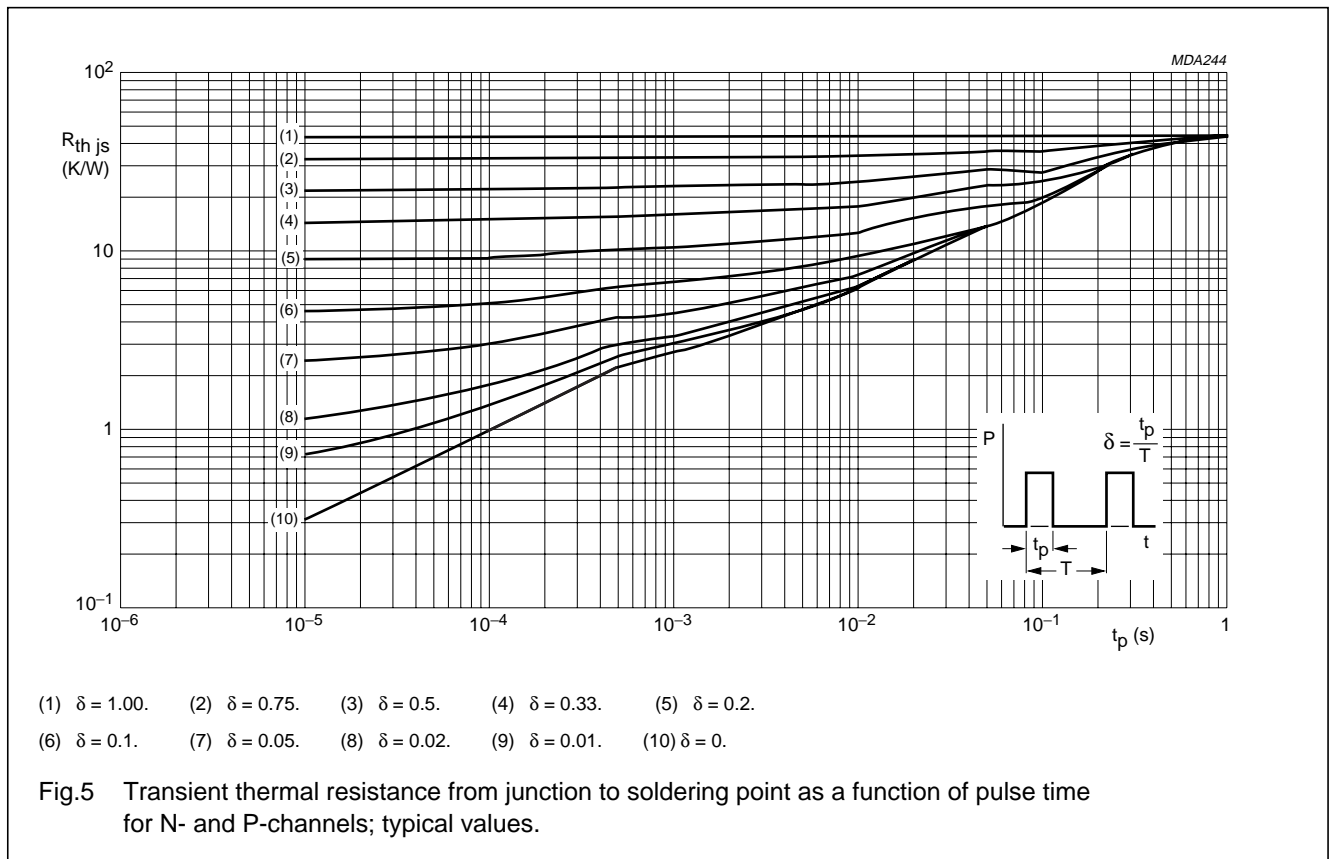


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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j-s}$	thermal resistance from junction to soldering point	43	K/W



CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Per FET						
$V_{(BR)DSS}$	drain-source breakdown voltage					
	N-channel	$V_{GS} = 0; I_D = 10\ \mu\text{A}$	300	–	–	V
	P-channel	$V_{GS} = 0; I_D = -10\ \mu\text{A}$	-300	–	–	V
V_{GSth}	gate-source threshold voltage					
	N-channel	$V_{GS} = V_{DS}; I_D = 1\ \text{mA}$	0.8	–	2	V
	P-channel	$V_{GS} = V_{DS}; I_D = -1\ \text{mA}$	-0.8	–	-2	V
I_{DSS}	drain-source leakage current					
	N-channel	$V_{GS} = 0; V_{DS} = 240\ \text{V}$	–	–	100	nA
	P-channel	$V_{GS} = 0; V_{DS} = -240\ \text{V}$	–	–	-100	nA

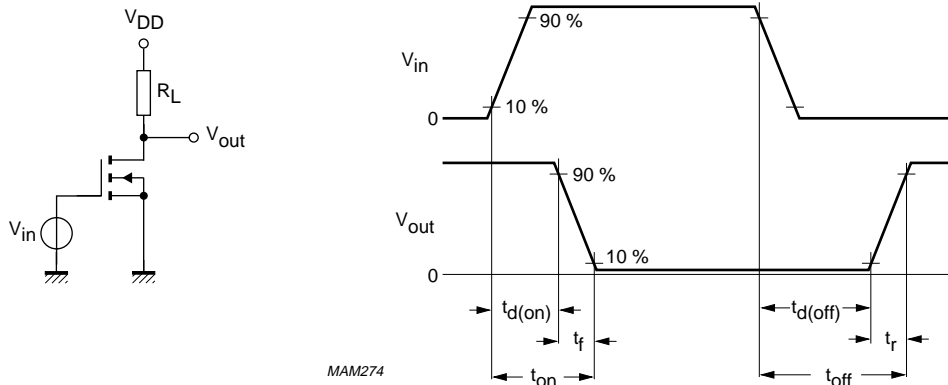
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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I_{GSS}	gate leakage current	$V_{GS} = \pm 20\text{ V}; V_{DS} = 0$				
	N-channel		–	–	± 100	nA
	P-channel		–	–	± 100	nA
R_{DSon}	drain-source on-state resistance					
	N-channel	$V_{GS} = 10\text{ V}; I_D = 170\text{ mA}$	–	–	8	Ω
	P-channel	$V_{GS} = -10\text{ V}; I_D = -115\text{ mA}$	–	–	17	Ω
C_{iss}	input capacitance					
	N-channel	$V_{GS} = 0; V_{DS} = 50\text{ V}; f = 1\text{ MHz}$	–	57	–	pF
	P-channel	$V_{GS} = 0; V_{DS} = -50\text{ V}; f = 1\text{ MHz}$	–	45	–	pF
C_{oss}	output capacitance					
	N-channel	$V_{GS} = 0; V_{DS} = 50\text{ V}; f = 1\text{ MHz}$	–	15	–	pF
	P-channel	$V_{GS} = 0; V_{DS} = -50\text{ V}; f = 1\text{ MHz}$	–	15	–	pF
C_{rss}	reverse transfer capacitance					
	N-channel	$V_{GS} = 0; V_{DS} = 50\text{ V}; f = 1\text{ MHz}$	–	2.6	–	pF
	P-channel	$V_{GS} = 0; V_{DS} = -50\text{ V}; f = 1\text{ MHz}$	–	3	–	pF
Q_G	total gate charge					
	N-channel	$V_{GS} = 10\text{ V}; V_{DS} = 50\text{ V}; I_D = 170\text{ mA}$	–	2097	–	pC
	P-channel	$V_{GS} = -10\text{ V}; V_{DS} = -50\text{ V}; I_D = -115\text{ mA}$	–	2137	–	pC
Q_{GS}	gate-source charge					
	N-channel	$V_{GS} = 10\text{ V}; V_{DS} = 50\text{ V}; I_D = 170\text{ mA}$	–	75	–	pC
	P-channel	$V_{GS} = -10\text{ V}; V_{DS} = -50\text{ V}; I_D = -115\text{ mA}$	–	68	–	pC
Q_{GD}	gate-drain charge					
	N-channel	$V_{GS} = 10\text{ V}; V_{DS} = 50\text{ V}; I_D = 170\text{ mA}$	–	527	–	pC
	P-channel	$V_{GS} = -10\text{ V}; V_{DS} = -50\text{ V}; I_D = -115\text{ mA}$	–	674	–	pC
Switching times						
t_{on}	turn-on time					
	N-channel	$V_{GS} = 0\text{ to }10\text{ V}; V_{DD} = 50\text{ V}; I_D = 170\text{ mA}$	–	2.5	10	ns
	P-channel	$V_{GS} = 0\text{ to }-10\text{ V}; V_{DD} = -50\text{ V}; I_D = -115\text{ mA}$	–	4	10	ns
t_{off}	turn-off time					
	N-channel	$V_{GS} = 10\text{ to }0\text{ V}; V_{DD} = 50\text{ V}; I_D = 170\text{ mA}$	–	17	30	ns
	P-channel	$V_{GS} = -10\text{ to }0\text{ V}; V_{DD} = -50\text{ V}; I_D = -115\text{ mA}$	–	25	35	ns

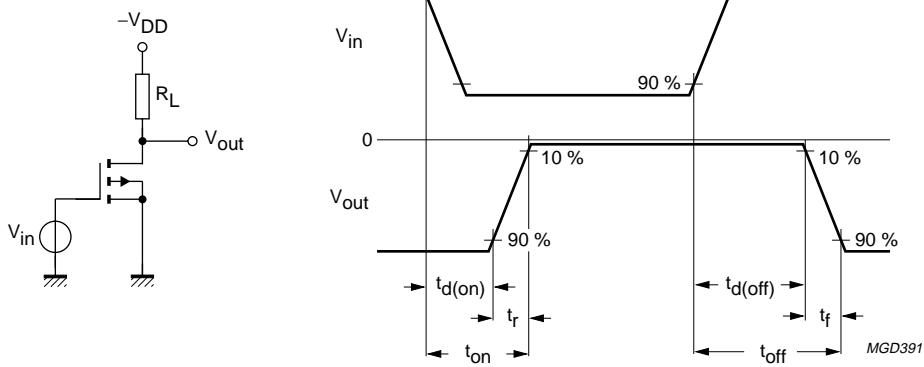
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MAM274

Fig.6 Switching times test circuit with input and output waveforms; N-channel.

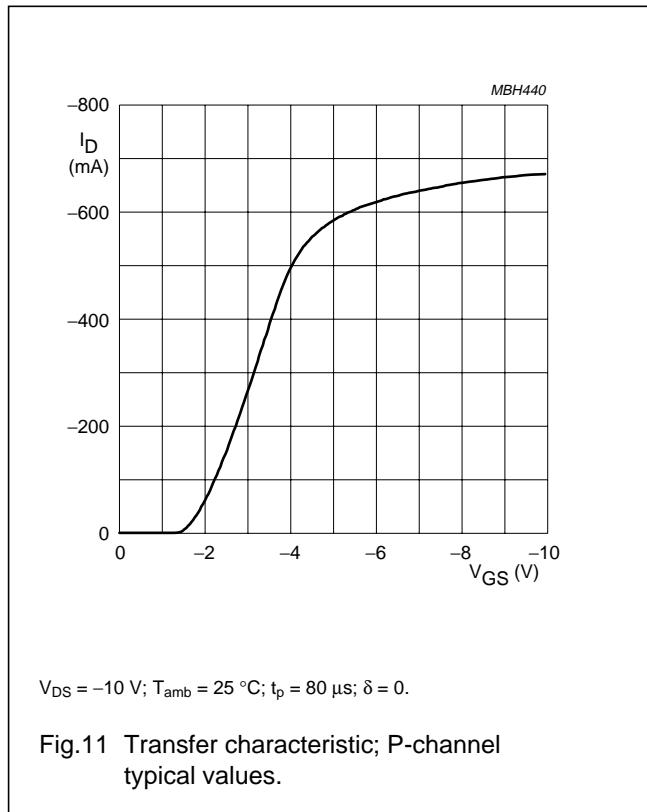
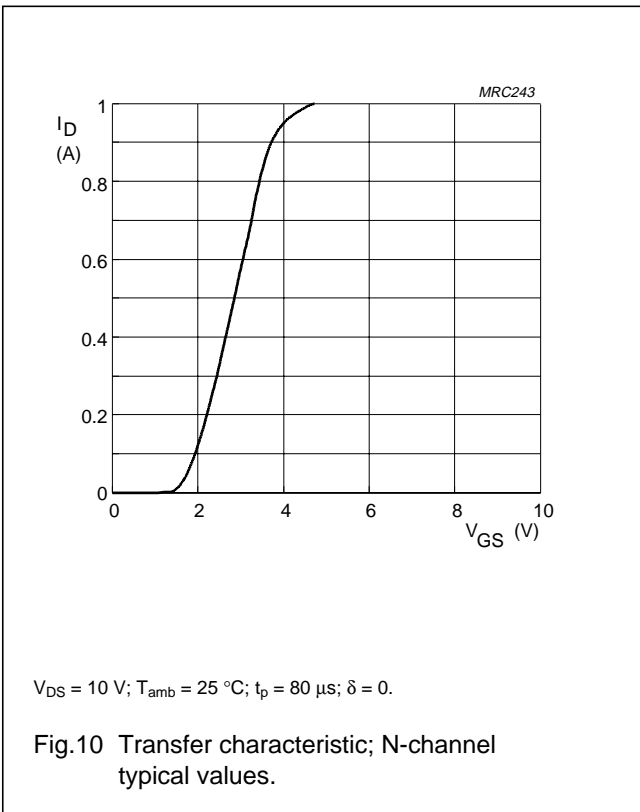
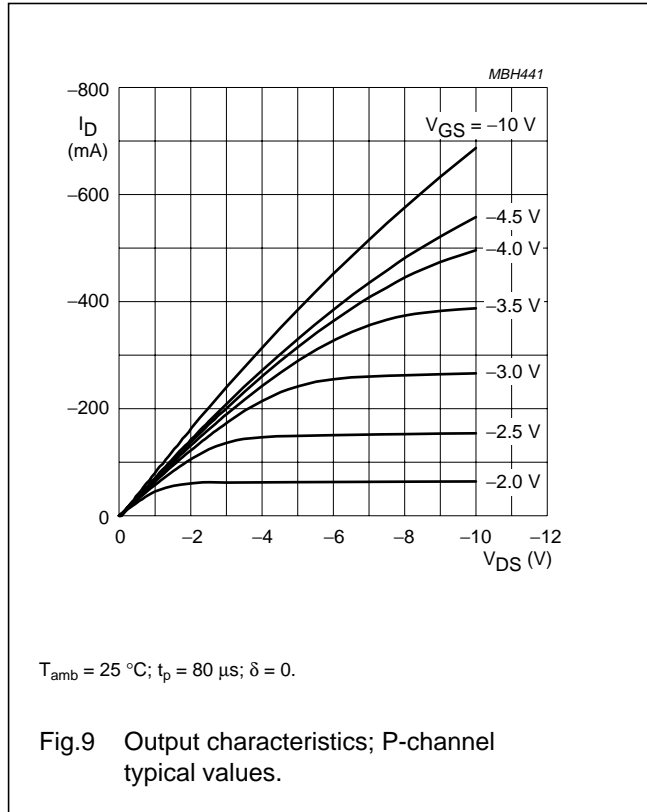
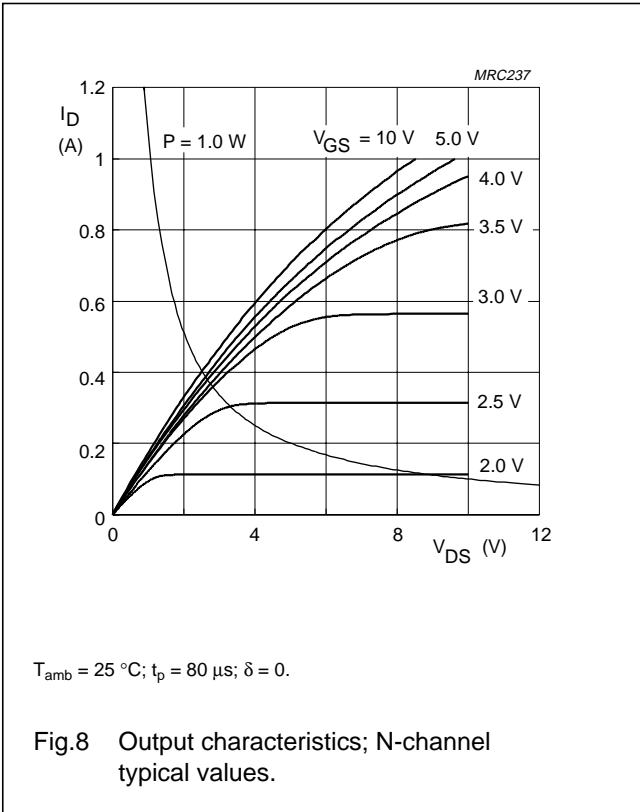


MGD391

Fig.7 Switching times test circuit with input and output waveforms; P-channel.

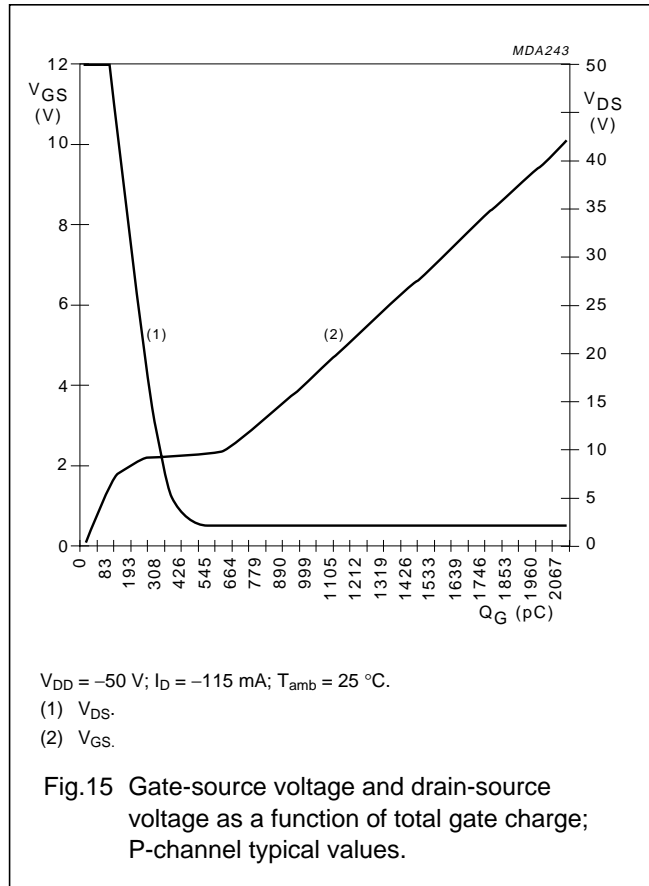
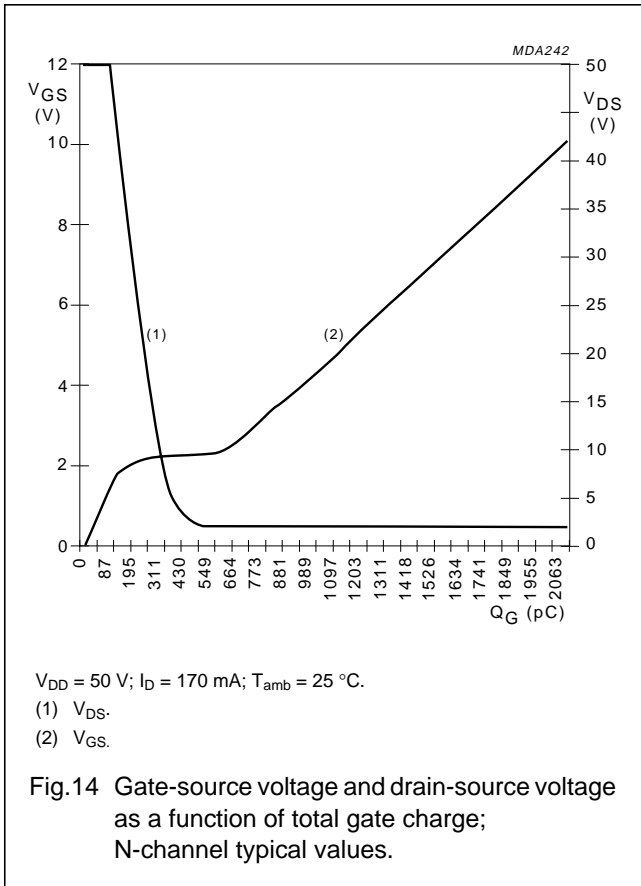
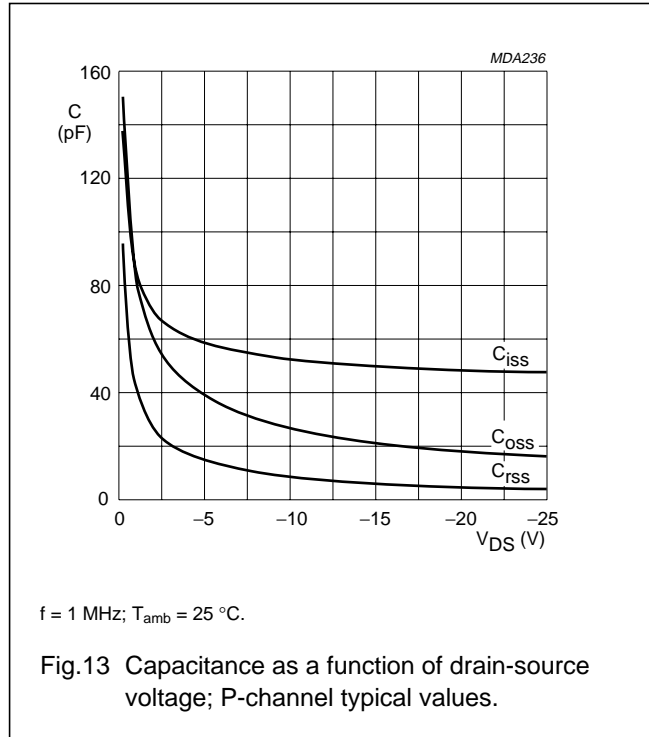
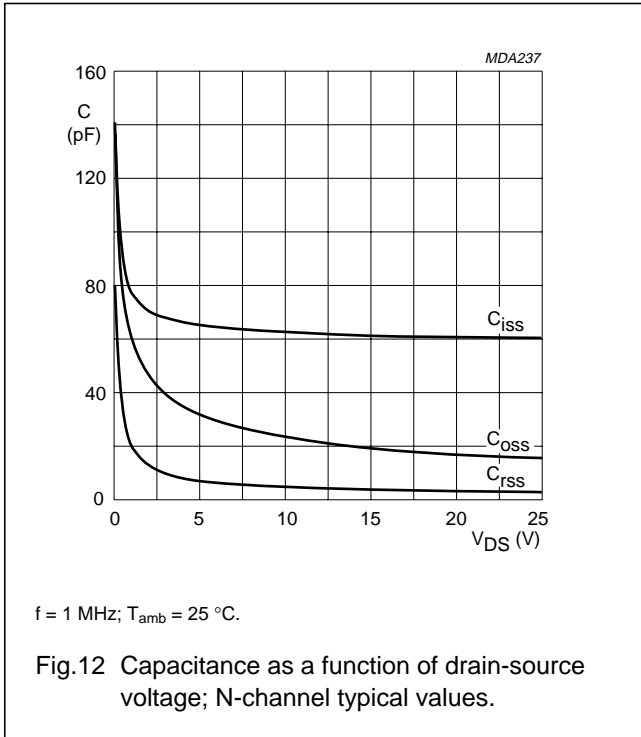
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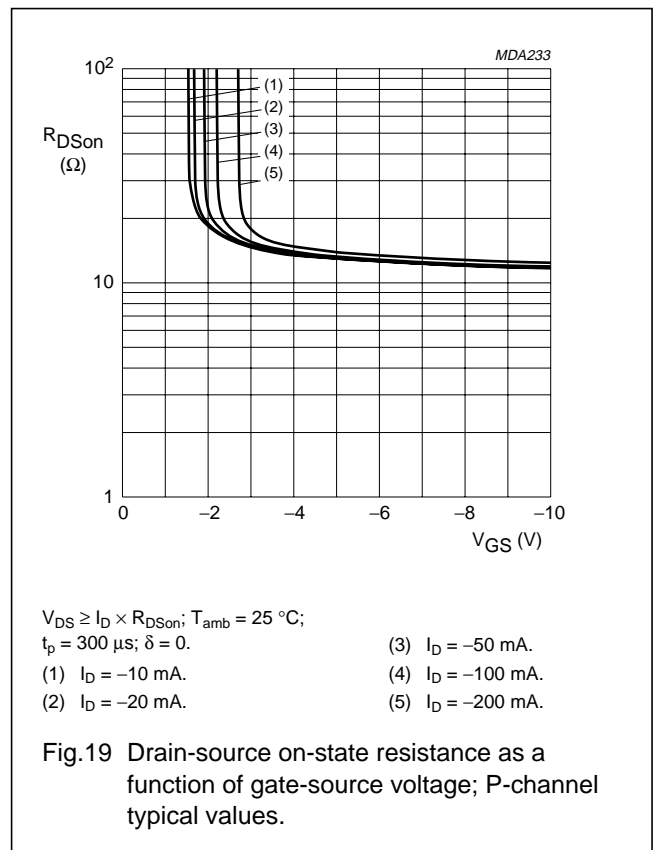
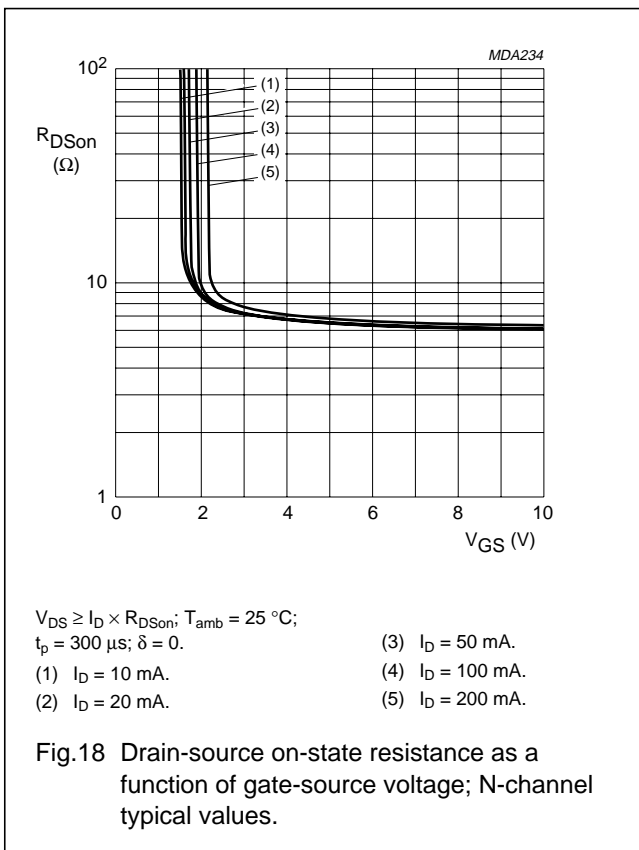
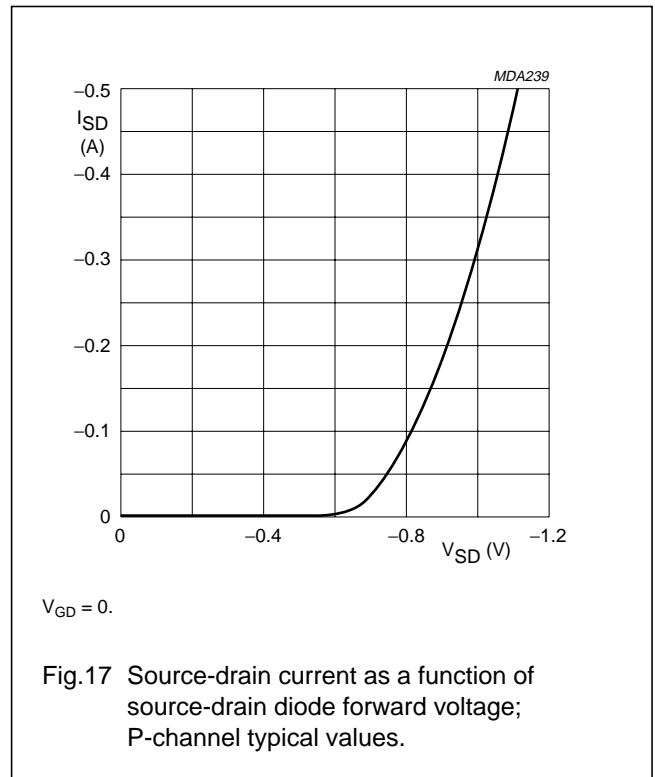
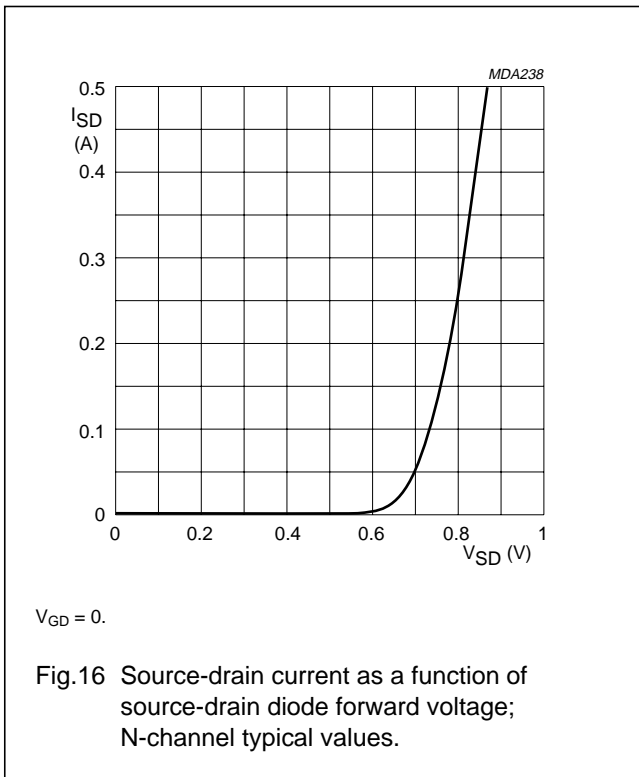
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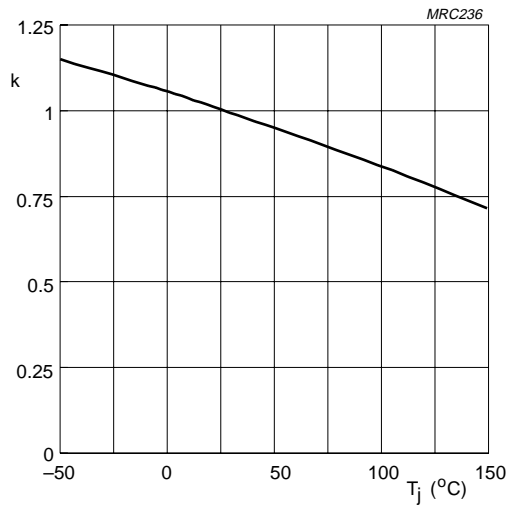
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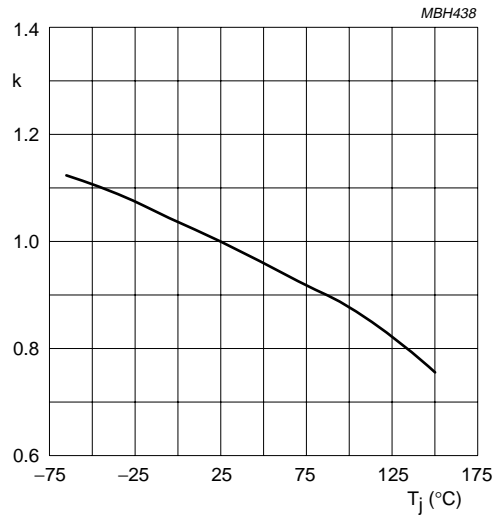
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$$k = \frac{V_{GSth} \text{ at } T_j}{V_{GSth} \text{ at } 25^\circ\text{C}}$$

V_{GSth} at V_{DS} = V_{GS}; I_D = 1 mA.

Fig.20 Temperature coefficient of gate-source threshold voltage as a function of junction temperature; N-channel, typical values.



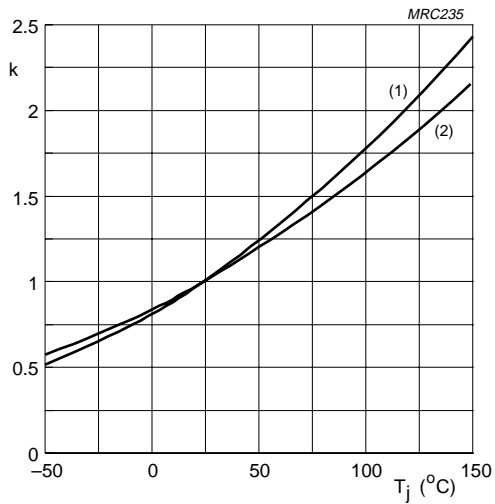
$$k = \frac{V_{GSth} \text{ at } T_j}{V_{GSth} \text{ at } 25^\circ\text{C}}$$

V_{GSth} at V_{DS} = V_{GS}; I_D = -1 mA.

Fig.21 Temperature coefficient of gate-source threshold voltage as function of junction temperature; P-channel typical values.

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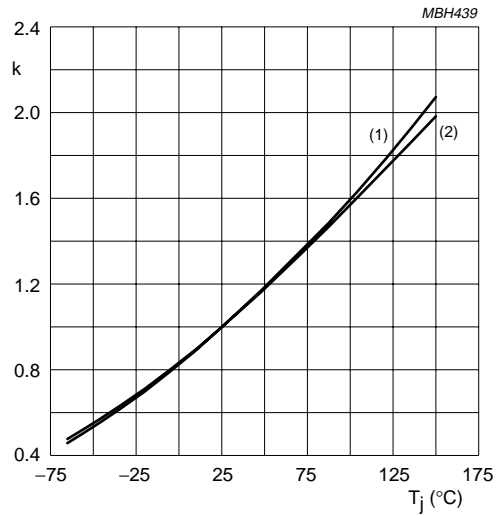
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$$k = \frac{R_{DSon} \text{ at } T_j}{R_{DSon} \text{ at } 25^\circ\text{C}}$$

- (1) R_{DSon} at $V_{GS} = 10\text{ V}$; $I_D = 250\text{ mA}$.
- (2) R_{DSon} at $V_{GS} = 2.4\text{ V}$; $I_D = 20\text{ mA}$.

Fig.22 Temperature coefficient of drain-source on-resistance as a function of junction temperature; N-channel typical values.



$$k = \frac{R_{DSon} \text{ at } T_j}{R_{DSon} \text{ at } 25^\circ\text{C}}$$

- (1) R_{DSon} at $V_{GS} = -4.5\text{ V}$; $I_D = -80\text{ mA}$.
- (2) R_{DSon} at $V_{GS} = -2.8\text{ V}$; $I_D = -50\text{ mA}$.

Fig.23 Temperature coefficient of drain-source on-resistance as a function of junction temperature; P-channel typical values.

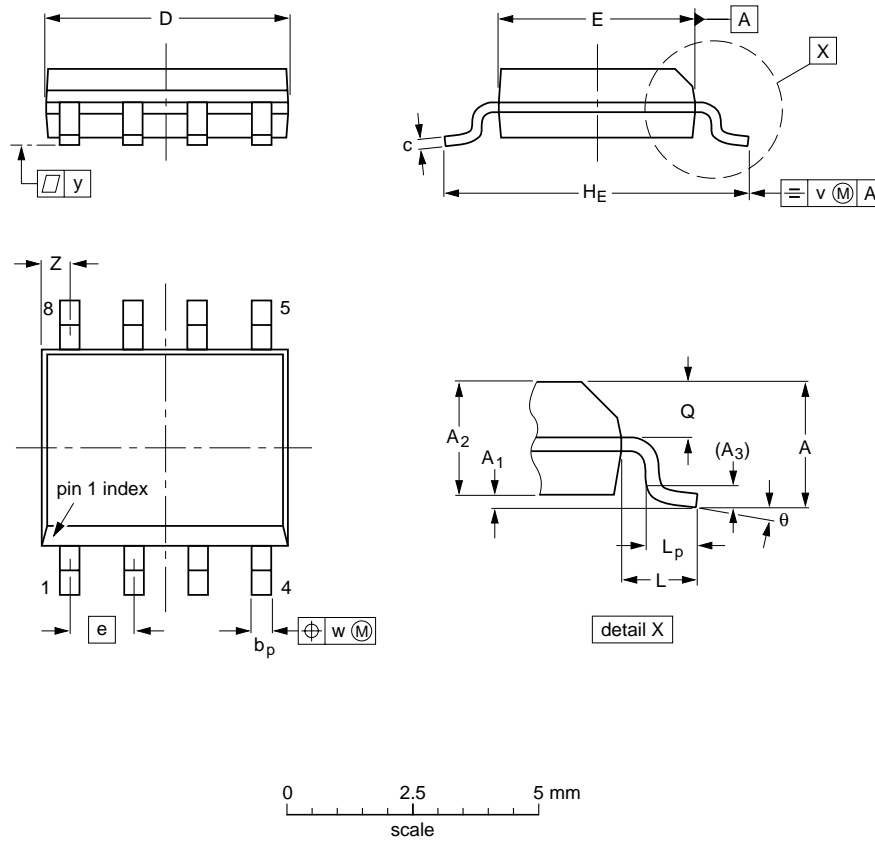
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PACKAGE OUTLINE

S08: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A ₁	A ₂	A ₃	b _p	c	D ⁽¹⁾	E ⁽²⁾	e	H _E	L	L _p	Q	v	w	y	z ⁽¹⁾	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8° 0°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.20 0.19	0.16 0.15	0.050	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	

Notes

1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ			
SOT96-1	076E03S	MS-012AA				95-02-04 97-05-22

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DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

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